

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









#### Important notice

Dear Customer,

On 7 February 2017 the former NXP Standard Product business became a new company with the tradename **Nexperia**. Nexperia is an industry leading supplier of Discrete, Logic and PowerMOS semiconductors with its focus on the automotive, industrial, computing, consumer and wearable application markets

In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

Instead of <a href="http://www.nxp.com">http://www.nxp.com</a>, <a href="http://www.semiconductors.philips.com/">http://www.nxp.com</a>, <a href="http://www.nexperia.com">http://www.nexperia.com</a>, <a href="http://www.nexperia.com">http://www.nexperia.com</a>)

Instead of sales.addresses@www.nxp.com or sales.addresses@www.semiconductors.philips.com, use salesaddresses@nexperia.com (email)

Replace the copyright notice at the bottom of each page or elsewhere in the document, depending on the version, as shown below:

- © NXP N.V. (year). All rights reserved or © Koninklijke Philips Electronics N.V. (year). All rights reserved

Should be replaced with:

- © Nexperia B.V. (year). All rights reserved.

If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

# **BAV70** series

# High-speed switching diodes Rev. 8 — 18 March 2015

**Product data sheet** 

#### 1. **Product profile**

### 1.1 General description

High-speed switching diodes, encapsulated in small Surface-Mounted Device (SMD) plastic packages.

Table 1. **Product overview** 

Type number	Package			Package	Configuration	
	NXP	JEITA	JEDEC	configuration		
BAV70	SOT23	-	TO-236AB	small	dual common cathode	
BAV70M	SOT883	SC-101	-	leadless ultra small	dual common cathode	
BAV70S	SOT363	SC-88	-	very small	quadruple common cathode/common cathode	
BAV70T	SOT416	SC-75	-	ultra small	dual common cathode	
BAV70W	SOT323	SC-70	-	very small	dual common cathode	

### 1.2 Features and benefits

- High switching speed: t<sub>rr</sub> ≤ 4 ns
- Low leakage current
- Small SMD plastic packages
- Low capacitance: C<sub>d</sub> ≤ 1.5 pF
- Reverse voltage: V<sub>R</sub> ≤ 100 V
- AEC-Q101 qualified

### 1.3 Applications

- High-speed switching
- General-purpose switching

### 1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode						
I <sub>R</sub>	reverse current	V <sub>R</sub> = 80 V	-	-	0.5	μΑ
$V_R$	reverse voltage		-	-	100	V
t <sub>rr</sub>	reverse recovery time	[1]	-	-	4	ns

[1] When switched from  $I_F$  = 10 mA to  $I_R$  = 10 mA;  $R_L$  = 100  $\Omega$ ; measured at  $I_R$  = 1 mA.



# 2. Pinning information

Table 3. Pinning

Pin	Description	Simplified outline	Symbol
BAV70; BAV	770T; BAV70W		
1	anode (diode 1)		
2	anode (diode 2)	3	3
3	common cathode	1 2 006aaa144	1 2 006aab034
BAV70M			
1	anode (diode 1)		3
2	anode (diode 2)	1 3	
3	common cathode	2 Transparent top view	1 2 006aab034
BAV70S			
1	anode (diode 1)	По Пт П4	
2	anode (diode 2)	6 5 4	6 5 4
3	common cathode (diode 3 and diode 4)	0	
4	anode (diode 3)	1 2 3	
5	anode (diode 4)		1 2 3
6	common cathode (diode 1 and diode 2)		006aab104

# 3. Ordering information

Table 4. Ordering information

Type number	Package					
	Name	Description	Version			
BAV70	-	plastic surface-mounted package; 3 leads	SOT23			
BAV70M	SC-101	leadless ultra small plastic package; 3 solder lands; body 1.0 $\times$ 0.6 $\times$ 0.5 mm	SOT883			
BAV70S	SC-88	plastic surface-mounted package; 6 leads	SOT363			
BAV70T	SC-75	plastic surface-mounted package; 3 leads	SOT416			
BAV70W	SC-70	plastic surface-mounted package; 3 leads	SOT323			

### 4. Marking

Table 5. Marking codes

Type number	Marking code <sup>[1]</sup>
BAV70	A4*
BAV70M	S4
BAV70S	A4*
BAV70T	A4
BAV70W	A4*

<sup>[1] \* = -:</sup> made in Hong Kong

# 5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per diode	'			,	
V <sub>RRM</sub>	repetitive peak reverse voltage		-	100	V
$V_R$	reverse voltage		-	100	V
l <sub>F</sub>	forward current				
	BAV70	T <sub>amb</sub> ≤ 25 °C	-	215	mA
	BAV70M	T <sub>s</sub> = 90 °C	-	150	mA
	BAV70S	T <sub>s</sub> = 60 °C	-	250	mA
	BAV70T	T <sub>s</sub> = 90 °C	-	150	mA
	BAV70W	$T_{amb} \le 25  ^{\circ}C$	-	175	mA
I <sub>FRM</sub>	repetitive peak forward current				
	BAV70		-	450	mA
	BAV70M		-	500	mA
	BAV70S		-	450	mA
	BAV70T		-	500	mA
	BAV70W		-	500	mA
I <sub>FSM</sub>	non-repetitive peak forward	square wave [1]			
	current	t <sub>p</sub> = 1 μs	-	4	Α
		t <sub>p</sub> = 1 ms	-	1	Α
		t <sub>p</sub> = 1 s	-	0.5	Α

<sup>\* =</sup> p: made in Hong Kong

<sup>\* =</sup> t: made in Malaysia

<sup>\* =</sup> W: made in China

 Table 6.
 Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P <sub>tot</sub>	total power dissipation	[2]			
	BAV70	T <sub>amb</sub> ≤ 25 °C	-	250	mW
	BAV70M	$T_{amb} \le 25  ^{\circ}C$	-	250	mW
	BAV70S	T <sub>s</sub> = 60 °C	-	350	mW
	BAV70T	T <sub>s</sub> = 90 °C	-	170	mW
	BAV70W	T <sub>amb</sub> ≤ 25 °C	-	200	mW
Per device	)				
l <sub>F</sub>	forward current				
	BAV70	T <sub>amb</sub> ≤ 25 °C	-	125	mA
	BAV70M	T <sub>s</sub> = 90 °C	-	75	mA
	BAV70S	T <sub>s</sub> = 60 °C	-	100	mA
	BAV70T	T <sub>s</sub> = 90 °C	-	75	mA
	BAV70W	T <sub>amb</sub> ≤ 25 °C	-	100	mA
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup>  $T_i = 25$  °C prior to surge.

### 6. Thermal characteristics

Table 7. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode	<u> </u>					
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air [1	1			
	BAV70		-	-	500	K/W
	BAV70M	[2	<u>l</u> -	-	500	K/W
	BAV70W		-	-	625	K/W
R <sub>th(j-t)</sub>	thermal resistance from junction to tie-point					
	BAV70		-	-	360	K/W
	BAV70W		-	-	300	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point					
	BAV70S		-	-	255	K/W
	BAV70T		-	-	350	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

BAV70\_SER

<sup>[2]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

<sup>[3]</sup> Reflow soldering is the only recommended soldering method.

<sup>[2]</sup> Reflow soldering is the only recommended soldering method.

### 7. Characteristics

Table 8. Characteristics

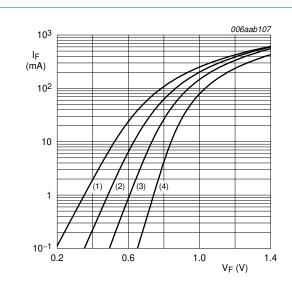
T<sub>amb</sub> = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Per diode			1			
V <sub>F</sub>	forward voltage	[1]				
	I <sub>F</sub> = 1 mA	-	-	715	mV	
		I <sub>F</sub> = 10 mA	-	-	855	mV
		$I_F = 50 \text{ mA}$	-	-	1	V
		I <sub>F</sub> = 150 mA	-	-	1.25	V
I <sub>R</sub>	reverse current	V <sub>R</sub> = 25 V	-	-	30	nA
		$V_{R} = 80 \text{ V}$	-	-	0.5	μΑ
		V <sub>R</sub> = 25 V; T <sub>j</sub> = 150 °C	-	-	30	μΑ
		$V_R = 80 \text{ V}; T_j = 150 ^{\circ}\text{C}$	-	-	100	μΑ
C <sub>d</sub>	diode capacitance	V <sub>R</sub> = 0 V; f = 1 MHz	-	-	1.5	pF
t <sub>rr</sub>	reverse recovery time	[2]	-	-	4	ns
$V_{FR}$	forward recovery voltage	[3]	-	-	1.75	V

<sup>[1]</sup> Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 

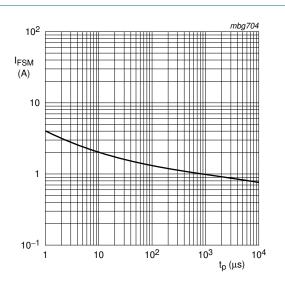
<sup>[2]</sup> When switched from  $I_F$  = 10 mA to  $I_R$  = 10 mA;  $R_L$  = 100  $\Omega;$  measured at  $I_R$  = 1 mA.

<sup>[3]</sup> When switched from  $I_F = 10$  mA;  $t_r = 20$  ns.



- (1)  $T_{amb} = 150 \, ^{\circ}C$
- (2)  $T_{amb} = 85 \, ^{\circ}C$
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb} = -40 \, ^{\circ}C$

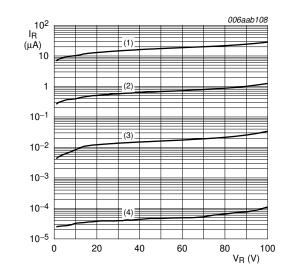
Fig 1. Forward current as a function of forward voltage; typical values



Based on square wave currents.

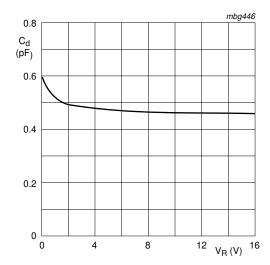
 $T_i = 25 \,^{\circ}\text{C}$ ; prior to surge

Fig 2. Non-repetitive peak forward current as a function of pulse duration; maximum values



- (1)  $T_{amb} = 150 \, ^{\circ}C$
- (2)  $T_{amb} = 85 \, ^{\circ}C$
- (3)  $T_{amb} = 25 \, ^{\circ}C$
- (4)  $T_{amb} = -40 \, ^{\circ}C$

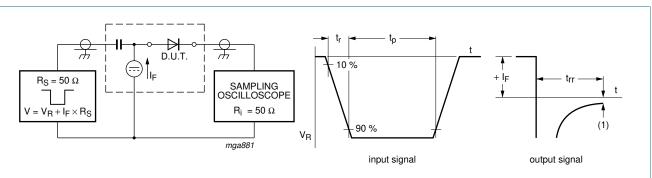
Fig 3. Reverse current as a function of reverse voltage; typical values



 $f = 1 \text{ MHz}; T_{amb} = 25 \text{ }^{\circ}\text{C}$ 

Fig 4. Diode capacitance as a function of reverse voltage; typical values

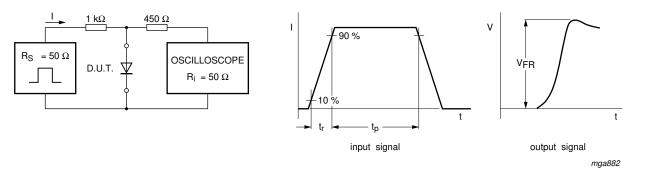
### 8. Test information



(1)  $I_R = 1 \text{ mA}$ 

Input signal: reverse pulse rise time  $t_r$  = 0.6 ns; reverse voltage pulse duration  $t_p$  = 100 ns; duty cycle  $\delta$  = 0.05 Oscilloscope: rise time  $t_r$  = 0.35 ns

### Fig 5. Reverse recovery time test circuit and waveforms



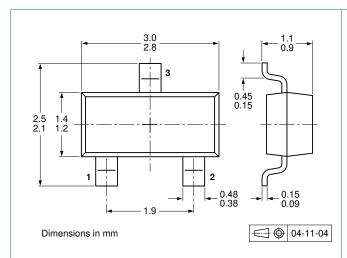
Input signal: forward pulse rise time  $t_r = 20$  ns; forward current pulse duration  $t_p \ge 100$  ns; duty cycle  $\delta \le 0.005$ 

Fig 6. Forward recovery voltage test circuit and waveforms

### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

### 9. Package outline



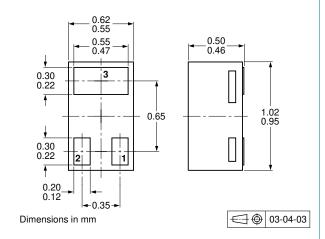
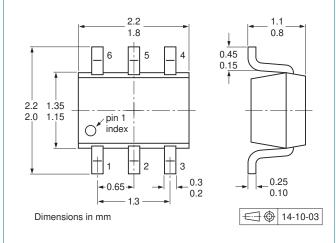


Fig 7. Package outline BAV70 (SOT23/TO-236AB)

Fig 8. Package outline BAV70M (SOT883/SC-101)



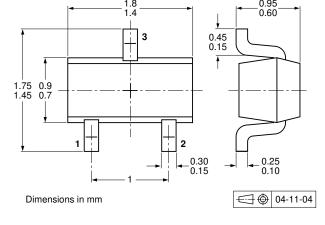


Fig 9. Package outline BAV70S (SOT363/SC-88)

Fig 10. Package outline BAV70T (SOT416/SC-75)

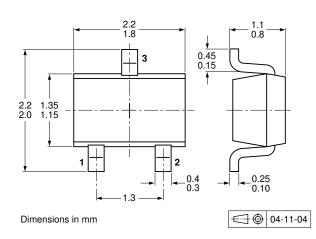


Fig 11. Package outline BAV70W (SOT323/SC-70)

### 10. Packing information

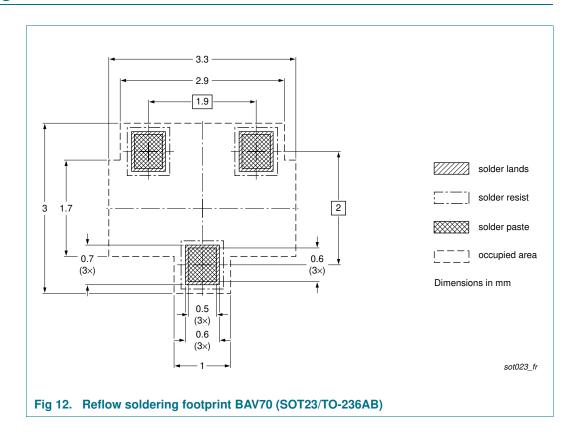
Table 9. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

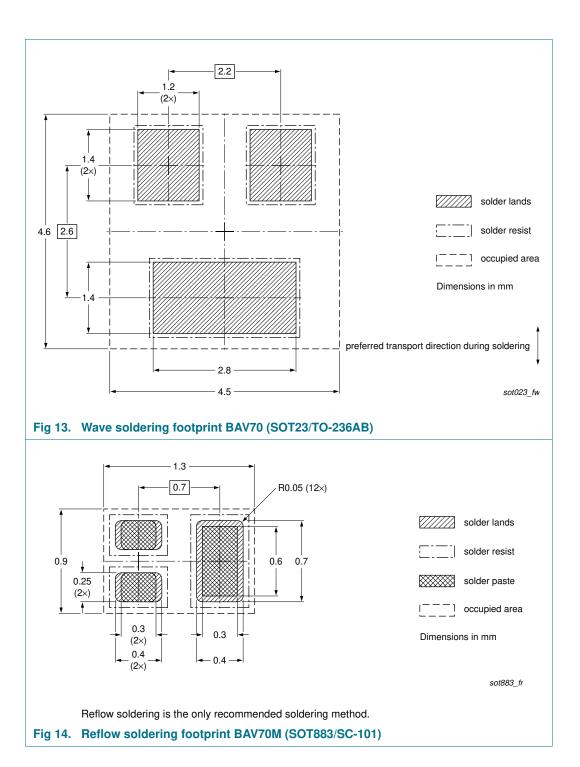
Type number	Package	Description	Packing q	uantity	
			3000	10000	
BAV70	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235	
BAV70M	SOT883	2 mm pitch, 8 mm tape and reel	-	-315	
BAV70S	SOT363	4 mm pitch, 8 mm tape and reel; T1 [2]	-115	-135	
		4 mm pitch, 8 mm tape and reel; T2	-125	-165	
BAV70T	SOT416	4 mm pitch, 8 mm tape and reel	-115	-135	
BAV70W	SOT323	4 mm pitch, 8 mm tape and reel	-115	-135	

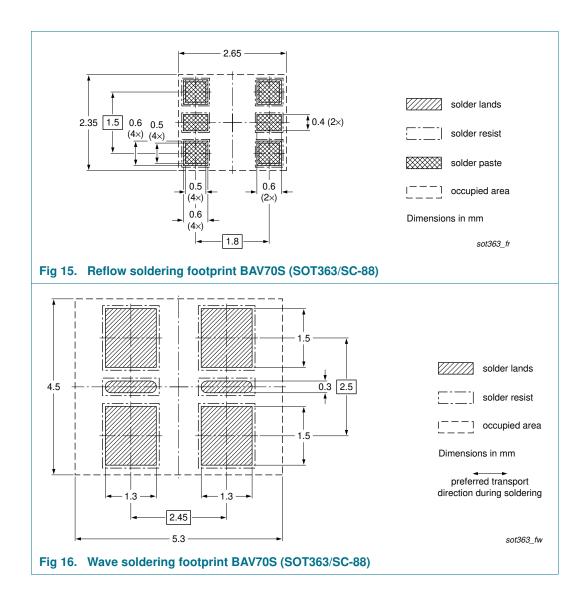
- [1] For further information and the availability of packing methods, see Section 14.
- [2] T1: normal taping
- [3] T2: reverse taping

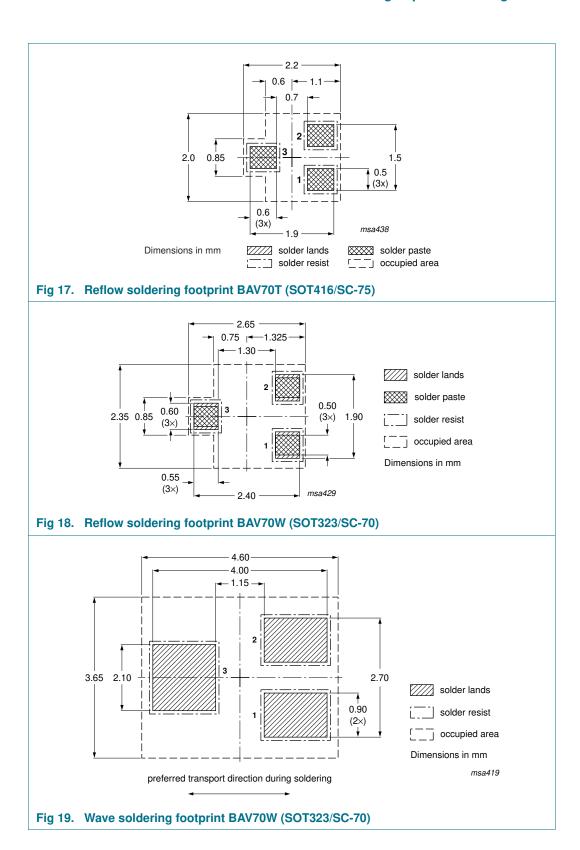
### 11. Soldering



**Product data sheet** 







# 12. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BAV70_SER v.8	20150318	Product data sheet	-	BAV70_SER_7		
Modifications:		<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>				
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>					
BAV70_SER_7	20071127	Product data sheet	-	BAV70_6 BAV70S_2 BAV70T_3 BAV70W_6		
BAV70_6	20020403	Product specification	-	BAV70_5		
BAV70S_2	19971021	Product specification	-	BAV70S_1		
BAV70T_3	20040204	Product specification	-	BAV70T_2		
BAV70W_6	20020405	Product specification	-	BAV70W_5		

### 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

### 13.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

**Product specification** — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

#### 13.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use in automotive applications — This NXP Semiconductors product has been qualified for use in automotive applications. Unless otherwise agreed in writing, the product is not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <a href="http://www.nxp.com/profile/terms">http://www.nxp.com/profile/terms</a>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

BAV70\_SER

All information provided in this document is subject to legal disclaimers.

© NXP Semiconductors N.V. 2015. All rights reserved.



No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

**Quick reference data** — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

**Translations** — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

### 13.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

### 14. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: <a href="mailto:salesaddresses@nxp.com">salesaddresses@nxp.com</a>

# **BAV70** series

### **High-speed switching diodes**

# 15. Contents

1	Product profile
1.1	General description
1.2	Features and benefits
1.3	Applications
1.4	Quick reference data 1
2	Pinning information
3	Ordering information
4	Marking 3
5	Limiting values 3
6	Thermal characteristics
7	Characteristics 5
8	Test information 7
8.1	Quality information
9	Package outline 8
10	Packing information 9
11	Soldering 9
12	Revision history
13	Legal information
13.1	Data sheet status
13.2	Definitions
13.3	Disclaimers
13.4	Trademarks
14	Contact information
15	Contents

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.